# **Q1 3-Phase TNPC Module**

The NXH25T120L2Q1PG/PTG is a case power module containing a three channel T-type neutral-point clamped (TNPC) circuit. Each channel has a two 1200 V, 25 A IGBTs with inverse diodes and two 650 V, 20 A IGBTs with inverse diodes. The module contains an NTC thermistor.

#### **Features**

- Low Package Height
- Compact 82.5 mm x 37.4 mm x 12 mm Package
- Press-fit Pins
- Options with Pre-applied Thermal Interface Material (TIM) and Without Pre-applied TIM
- Thermistor

#### **Typical Applications**

- Solar Inverters
- UPS

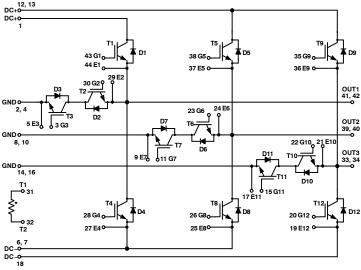
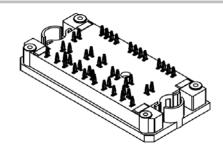


Figure 1. NXH25T120L2Q1PG/PTG Schematic Diagram



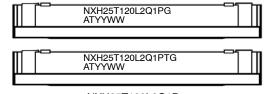
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Q1 3-TNPC PRESS FIT CASE 180AS

#### **DEVICE MARKING**

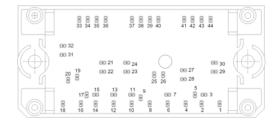


NXH25T120L2Q1P or NXH25T120L2Q1PT = Specific Device Code

G = Pb-Free Package

AT = Assembly & Test Site Code YYWW = Year and Work Week Code

#### **PIN ASSIGNMENTS**



#### **ORDERING INFORMATION**

See detailed ordering and shipping information on page 5 of this data sheet.

Table 1. MAXIMUM RATINGS (Note 1)

Rating	Symbol	Value	Unit
HALF BRIDGE IGBT			•
Collector-Emitter Voltage	V <sub>CES</sub>	1200	V
Gate-Emitter Voltage	V <sub>GE</sub>	±20	V
Continuous Collector Current @ T <sub>c</sub> = 80°C (T <sub>J</sub> = 175°C)	I <sub>C</sub>	25	А
Pulsed Collector Current (T <sub>J</sub> = 175°C)	I <sub>Cpulse</sub>	75	А
Maximum Power Dissipation (T <sub>J</sub> = 175°C)	P <sub>tot</sub>	81	W
Short Circuit Withstand Time @ $V_{GE}$ = 15 V, $V_{CE}$ = 600 V, $T_{J} \le 150^{\circ}C$	T <sub>sc</sub>	5	μs
Minimum Operating Junction Temperature	T <sub>JMIN</sub>	-40	°C
Maximum Operating Junction Temperature	T <sub>JMAX</sub>	150	°C
NEUTRAL POINT IGBT			
Collector-Emitter Voltage	V <sub>CES</sub>	650	V
Gate-Emitter Voltage	V <sub>GE</sub>	±20	V
Continuous Collector Current @ T <sub>c</sub> = 80°C (T <sub>J</sub> = 175°C)	I <sub>C</sub>	20	Α
Pulsed Collector Current (T <sub>J</sub> = 175°C)	I <sub>Cpulse</sub>	60	А
Maximum Power Dissipation (T <sub>J</sub> = 175°C)	P <sub>tot</sub>	50	W
Short Circuit Withstand Time @ $V_{GE}$ = 15 V, $V_{CE}$ = 400 V, $T_{J} \le 150^{\circ}C$	T <sub>sc</sub>	5	μs
Minimum Operating Junction Temperature	T <sub>JMIN</sub>	-40	°C
Maximum Operating Junction Temperature	T <sub>JMAX</sub>	150	°C
HALF BRIDGE DIODE			
Peak Repetitive Reverse Voltage	V <sub>RRM</sub>	1200	V
Continuous Forward Current @ T <sub>c</sub> = 80°C (T <sub>J</sub> = 175°C)	I <sub>F</sub>	15	Α
Repetitive Peak Forward Current (T <sub>J</sub> = 175°C)	I <sub>FRM</sub>	45	А
Maximum Power Dissipation (T <sub>J</sub> = 175°C)	P <sub>tot</sub>	43	W
Minimum Operating Junction Temperature	T <sub>JMIN</sub>	-40	°C
Maximum Operating Junction Temperature	T <sub>JMAX</sub>	150	°C
NEUTRAL POINT DIODE			
Peak Repetitive Reverse Voltage	V <sub>RRM</sub>	650	V
Continuous Forward Current @ T <sub>c</sub> = 80°C (T <sub>J</sub> = 175°C)	IF	15	А
Repetitive Peak Forward Current (T <sub>J</sub> = 175°C)	I <sub>FRM</sub>	45	А
Maximum Power Dissipation (T <sub>J</sub> = 175°C)	P <sub>tot</sub>	39	W
Minimum Operating Junction Temperature	T <sub>JMIN</sub>	-40	°C
Maximum Operating Junction Temperature	T <sub>JMAX</sub>	150	°C
THERMAL PROPERTIES			
Storage Temperature range	T <sub>stg</sub>	-40 to 125	°C
INSULATION PROPERTIES			
Isolation test voltage, t = 1 sec, 60Hz	V <sub>is</sub>	3000	$V_{RMS}$
Creepage distance		12.7	mm

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

#### **Table 2. RECOMMENDED OPERATING RANGES**

Rating	Symbol	Min	Max	Unit
Module Operating Junction Temperature	T,1	-40	150	°C

Functional operation above the stresses listed in the Recommended Operating Ranges is not implied. Extended exposure to stresses beyond the Recommended Operating Ranges limits may affect device reliability.

<sup>1.</sup> Refer to ELECTRICAL CHĂRACTERISTICS, RECOMMENDED OPERATING RANGES and/or APPLICATION INFORMATION for Safe Operating parameters.

Table 3. ELECTRICAL CHARACTERISTICS  $T_J$  =  $25^{\circ}\text{C}$  unless otherwise noted

Parameter	Test Conditions	Symbol	Min	Тур	Max	Unit
HALF BRIDGE IGBT CHARACTERISTICS						
Collector-Emitter Cutoff Current	V <sub>GE</sub> = 0 V, V <sub>CE</sub> = 1200 V	I <sub>CES</sub>	-	_	300	μΑ
Collector-Emitter Saturation Voltage	V <sub>GE</sub> = 15 V, I <sub>C</sub> = 25 A, T <sub>J</sub> = 25°C	V <sub>CE(sat)</sub>	-	1.90	2.50	V
	V <sub>GE</sub> = 15 V, I <sub>C</sub> = 25 A, T <sub>J</sub> = 125°C		-	1.96	_	1
Gate-Emitter Threshold Voltage	$V_{GE} = V_{CE}$ , $I_C = 1.5 \text{ mA}$	$V_{GE(TH)}$	4.90	5.49	6.50	V
Gate Leakage Current	V <sub>GE</sub> = 20 V, V <sub>CE</sub> = 0 V	I <sub>GES</sub>	=	-	300	nA
Turn-on Delay Time	T <sub>J</sub> = 25°C	t <sub>d(on)</sub>	=	59	_	ns
Rise Time	$V_{CE}$ = 350 V, $I_{C}$ = 15 A $V_{GE}$ = ±15 V, $R_{G}$ = 15 $Ω$	t <sub>r</sub>	-	26	_	
Turn-off Delay Time	VGE = ±13 V, NG = 13 ½	t <sub>d(off)</sub>	-	242	_	1
Fall Time	7	t <sub>f</sub>	-	52	_	1
Turn-on Switching Loss per Pulse	7	E <sub>on</sub>	-	220	_	μJ
Turn off Switching Loss per Pulse	7	E <sub>off</sub>	_	240	_	1
Turn-on Delay Time	T <sub>J</sub> = 125°C	t <sub>d(on)</sub>	=	48	_	ns
Rise Time	V <sub>CE</sub> = 350 V, I <sub>C</sub> = 15 A	t <sub>r</sub>	_	29	_	1
Turn-off Delay Time	$V_{GE}$ = ±15 V, $R_{G}$ = 15 $\Omega$	t <sub>d(off)</sub>	_	293	_	1
Fall Time	1	t <sub>f</sub>	=	258	_	1
Turn-on Switching Loss per Pulse		E <sub>on</sub>	=	400	-	μJ
Turn off Switching Loss per Pulse	1	E <sub>off</sub>	=	710	_	1
Input Capacitance	V <sub>CE</sub> = 20 V, V <sub>GE</sub> = 0 V. f = 10 kHz	C <sub>ies</sub>	=	8502	-	pF
Output Capacitance	7	C <sub>oes</sub>	_	187	_	1
Reverse Transfer Capacitance	7	C <sub>res</sub>	-	154	_	1
Total Gate Charge	$V_{CE} = 600 \text{ V}, I_{C} = 25 \text{ A}, V_{GE} = \pm 15 \text{ V}$	$Q_g$	-	352	_	nC
Thermal Resistance - chip-to-heatsink	Thermal grease, Thickness $\leq$ 2.25 Mil, $\lambda$ = 2.9 W/mK	R <sub>thJH</sub>	-	1.17	_	°C/W
NEUTRAL POINT DIODE CHARACTERIS	rics	•		•		
Diode Forward Voltage	I <sub>F</sub> = 15 A, T <sub>J</sub> = 25°C	V <sub>F</sub>	=	2.43	_	V
	I <sub>F</sub> = 15 A, T <sub>J</sub> = 125°C	1	=	1.60	_	1
Combined IGBT + Diode Voltage Drop	I <sub>F</sub> = 15 A, T <sub>J</sub> = 25°C	$V_{DT}$	=	3.76	4.60	V
Reverse Recovery Time	T <sub>J</sub> = 25°C	t <sub>rr</sub>	_	59	_	ns
Reverse Recovery Charge	$V_{CE} = 350 \text{ V, } I_{C} = 15 \text{ A}$ $V_{GE} = \pm 15 \text{ V, } R_{G} = 15 \Omega$	Q <sub>rr</sub>	_	0.21	_	μС
Peak Reverse Recovery Current	$V_{GE} = \pm 15 \text{ V}, \text{ H}_{G} = 15 \Omega$	I <sub>RRM</sub>	_	7	_	Α
Peak Rate of Fall of Recovery Current	7	di/dt	=	106	_	A/μs
Reverse Recovery Energy	7	E <sub>rr</sub>	_	40	_	μJ
Reverse Recovery Time	T <sub>J</sub> = 125°C	t <sub>rr</sub>	-	67	-	ns
Reverse Recovery Charge	V <sub>CE</sub> = 350 V, I <sub>C</sub> = 15 A	Q <sub>rr</sub>	_	0.69	_	μС
Peak Reverse Recovery Current	$V_{GE} = \pm 15 \text{ V}, R_{G} = 15 \Omega$	I <sub>RRM</sub>	_	19	_	Α
Peak Rate of Fall of Recovery Current	1	di/dt	_	451	_	A/μs
Reverse Recovery Energy	1	E <sub>rr</sub>	=	100	=	μJ
Thermal Resistance - chip-to-heatsink	Thermal grease, Thickness $\leq$ 2.25 Mil, $\lambda$ = 2.9 W/mK	R <sub>thJH</sub>	_	2.45	_	°C/W

Table 3. ELECTRICAL CHARACTERISTICS T<sub>.1</sub> = 25°C unless otherwise noted

Parameter Test Conditions		Symbol	Min	Тур	Max	Unit
NEUTRAL POINT IGBT CHARACTERISTI	cs	•		•	•	•
Collector-Emitter Cutoff Current	V <sub>GE</sub> = 0 V, V <sub>CE</sub> = 650 V	I <sub>CES</sub>	-	_	200	μΑ
Collector-Emitter Saturation Voltage	V <sub>GE</sub> = 15 V, I <sub>C</sub> = 20 A, T <sub>J</sub> = 25°C	V <sub>CE(sat)</sub>	=	1.49	-	V
	V <sub>GE</sub> = 15 V, I <sub>C</sub> = 20 A, T <sub>J</sub> = 125°C	1	_	1.61	-	
Gate-Emitter Threshold Voltage	$V_{GE} = V_{CE}, I_{C} = 1.65 \text{ mA}$	V <sub>GE(TH)</sub>	4.70	5.68	6.50	V
Gate Leakage Current	V <sub>GE</sub> = 20 V, V <sub>CE</sub> = 0 V	I <sub>GES</sub>	_	_	200	nA
Turn-on Delay Time	T <sub>J</sub> = 25°C	t <sub>d(on)</sub>	_	33	_	ns
Rise Time	V <sub>CE</sub> = 350 V, I <sub>C</sub> = 15 A	t <sub>r</sub>	_	18	_	
Turn-off Delay Time	$V_{GE}$ = ±15V, $R_{G}$ = 15 $\Omega$	t <sub>d(off)</sub>	_	126	-	1
Fall Time		t <sub>f</sub>	_	43	_	
Turn-on Switching Loss per Pulse		E <sub>on</sub>	_	250	_	μJ
Turn off Switching Loss per Pulse	7	E <sub>off</sub>	_	180	_	
Turn-on Delay Time	T <sub>J</sub> = 125°C	t <sub>d(on)</sub>	=	31	-	ns
Rise Time	$V_{CE} = 350 \text{ V, } I_{C} = 15 \text{ A}$	t <sub>r</sub>	-	19	-	
Turn-off Delay Time	$V_{GE} = \pm 15 \text{ V}, R_{G} = 15 \Omega$	t <sub>d(off)</sub>	-	138	-	
Fall Time		t <sub>f</sub>	-	72	-	
Turn-on Switching Loss per Pulse		E <sub>on</sub>	-	390	-	uJ
Turn off Switching Loss per Pulse		E <sub>off</sub>	-	300	-	
Input Capacitance	V <sub>CE</sub> = 20 V, V <sub>GE</sub> = 0 V, f = 10 kHz	C <sub>ies</sub>	-	3837	-	pF
Output Capacitance		C <sub>oes</sub>	-	127	-	
Reverse Transfer Capacitance		C <sub>res</sub>	=	104	-	
Total Gate Charge	V <sub>CE</sub> = 480 V, I <sub>C</sub> = 20 A, V <sub>GE</sub> = ±15 V	Qg	=	166	-	nC
Thermal Resistance - chip-to-heatsink	Thermal grease, Thickness $\leq$ 2.25 Mil, $\lambda$ = 2.9 W/mK	$R_{thJH}$	-	1.90	_	°C/W
HALF BRIDGE DIODE CHARACTERISTIC	es .					
Diode Forward Voltage	I <sub>F</sub> = 15 A, T <sub>J</sub> = 25°C	V <sub>F</sub>	-	2.47	3	V
	I <sub>F</sub> = 15 A, T <sub>J</sub> = 125°C	1	-	1.97	-	
Reverse Recovery Time	T <sub>J</sub> = 25°C	t <sub>rr</sub>	-	63	-	ns
Reverse Recovery Charge	$V_{CE} = 350 \text{ V, } I_{C} = 15 \text{ A}$	Q <sub>rr</sub>	-	0.45	-	μС
Peak Reverse Recovery Current	$V_{GE} = \pm 15 \text{ V}, R_{G} = 15 \Omega$	I <sub>RRM</sub>	-	17	-	Α
Peak Rate of Fall of Recovery Current		di/dt	-	313	-	A/μs
Reverse Recovery Energy		E <sub>rr</sub>	-	70	-	μJ
Reverse Recovery Time	T <sub>J</sub> = 125°C	t <sub>rr</sub>	_	233	_	ns
Reverse Recovery Charge	$V_{CE} = 350 \text{ V, } I_{C} = 15 \text{ A}$	$Q_{rr}$	_	1.55	_	μС
Peak Reverse Recovery Current	$V_{GE} = \pm 15 \text{ V}, R_{G} = 15 \Omega$	I <sub>RRM</sub>	_	22	_	Α
Peak Rate of Fall of Recovery Current	1	di/dt	_	76	_	A/μs
Reverse Recovery Energy	1	E <sub>rr</sub>	_	360	-	μJ
Thermal Resistance - chip-to-heatsink	Thermal grease, Thickness ≤ 2.25 Mil, λ = 2.9 W/mK	$R_{thJH}$	-	2.21	_	°C/W

Table 3. ELECTRICAL CHARACTERISTICS  $T_J = 25^{\circ}C$  unless otherwise noted

Parameter	Test Conditions Symi		Min	Тур	Max	Unit
THERMISTOR CHARACTERISTICS						
Nominal resistance	T = 25°C	R <sub>25</sub>	-	22	-	kΩ
Nominal resistance	T = 100°C	R <sub>100</sub>	_	1468	-	Ω
Deviation of R25		ΔR/R	-5		5	%
Power dissipation		P <sub>D</sub>	_	200	-	mW
Power dissipation constant			_	2	-	mW/K
B-value	B(25/50), tolerance ±3%		_	3950	-	K
B-value	B(25/100), tolerance ±3%		_	3998	-	K

#### **ORDERING INFORMATION**

Orderable Part Number	Marking	Package	Shipping
NXH25T120L2Q1PG	NXH25T120L2Q1PG	Q1 3-Phase TNPC - Case 180AS Press-fit Pins (Pb - Free)	21 Units / Blister Tray
NXH25T120L2Q1PTG	NXH25T120L2Q1PTG	Q1 3-Phase TNPC - Case 180AS Press-fit Pins with pre-applied thermal interface material (TIM) (Pb - Free)	21 Units / Blister Tray

#### TYPICAL CHARACTERISTICS - HALF BRIDGE IGBT AND DIODE

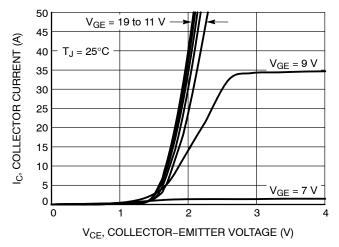


Figure 2. Typical Output Characteristics

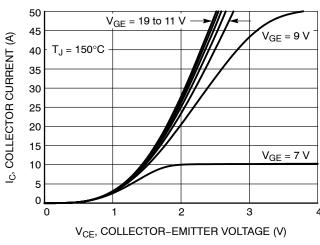


Figure 3. Typical Output Characteristics

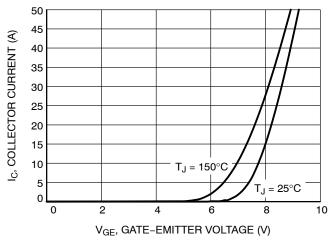


Figure 4. Typical Transfer Characteristics

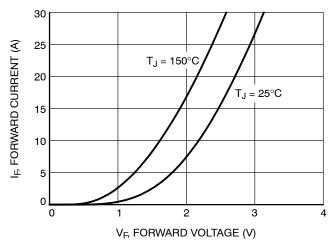


Figure 5. Diode Forward Characteristics

#### TYPICAL CHARACTERISTICS - HALF BRIDGE IGBT AND DIODE

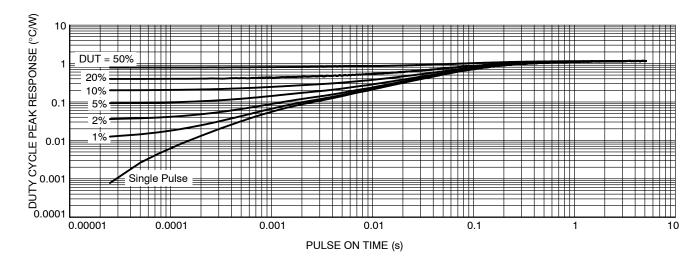


Figure 6. Transient Thermal Impedance (Half Bridge IGBT)

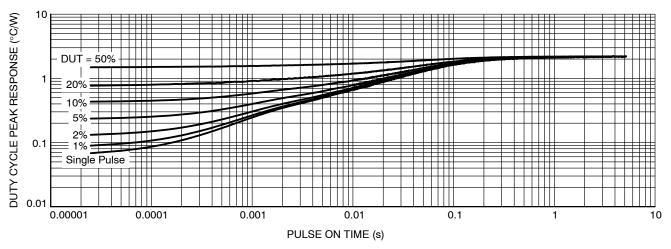


Figure 7. Transient Thermal Impedance (Half Bridge Diode)

#### TYPICAL CHARACTERISTICS - HALF BRIDGE IGBT AND DIODE

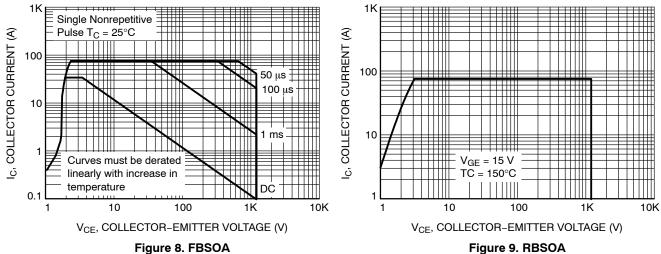


Figure 8. FBSOA

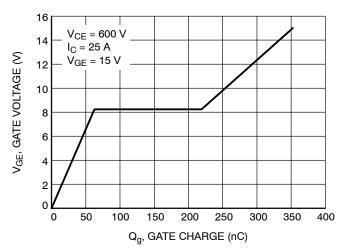
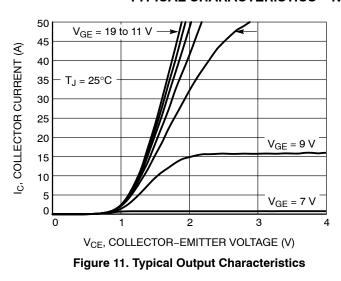


Figure 10. Gate Voltage vs. Gate Charge

#### TYPICAL CHARACTERISTICS - NEUTRAL POINT IGBT AND DIODE



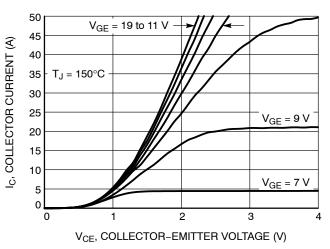


Figure 12. Typical Output Characteristics

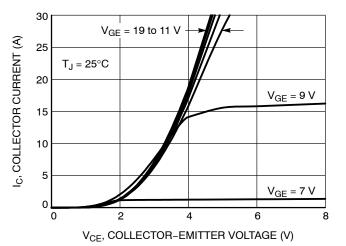


Figure 13. Typical Output Characteristics  $(I_C \text{ vs. } V_{DT})$ 

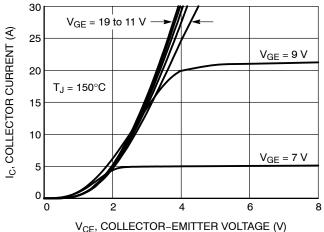


Figure 14. Typical Output Characteristics (I<sub>C</sub> vs. V<sub>DT</sub>)

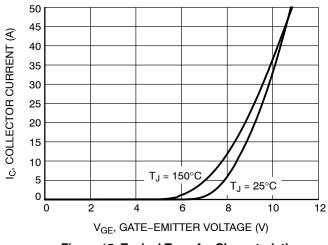


Figure 15. Typical Transfer Characteristics

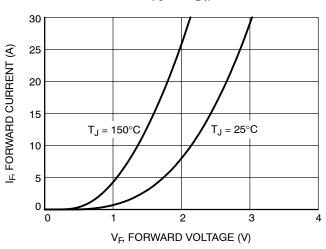


Figure 16. Diode Forward Characteristics

#### TYPICAL CHARACTERISTICS - NEUTRAL POINT IGBT AND DIODE

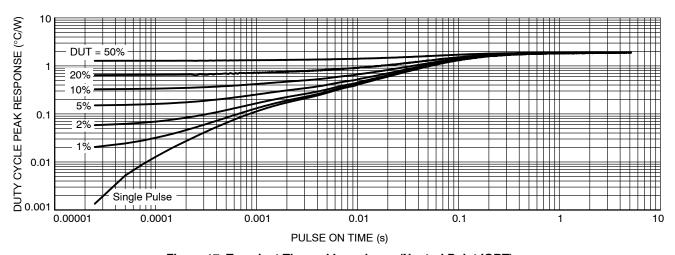


Figure 17. Transient Thermal Impedance (Neutral Point IGBT)

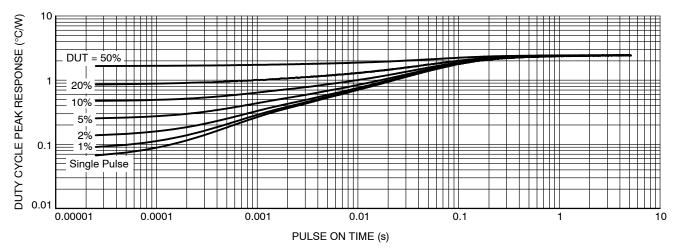


Figure 18. Transient Thermal Impedance (Neutral Point Diode)

#### TYPICAL CHARACTERISTICS - NEUTRAL POINT IGBT AND DIODE

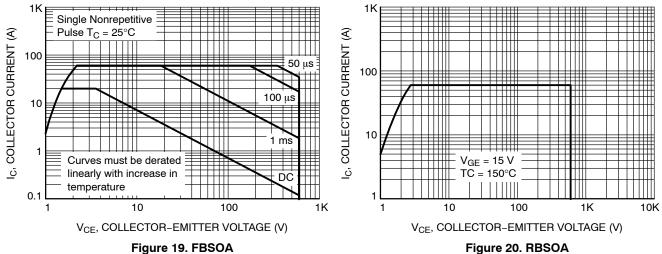


Figure 19. FBSOA

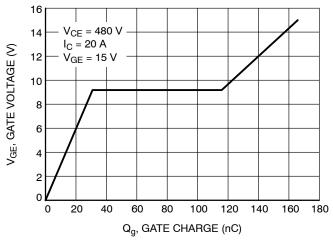
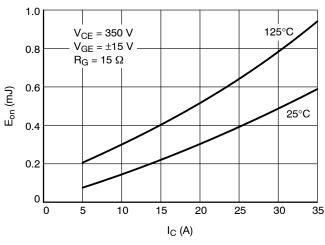


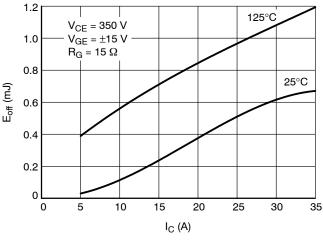
Figure 21. Gate Voltage vs. Gate Charge



125°C V<sub>CE</sub> = 350 V 0.5  $V_{GE} = \pm 15 V$  $I_{C} = 15 A$ E<sub>on</sub> (mJ) 0.4 25°C 0.3 0.2 0.1 20 15 30 35  $R_G(\Omega)$ 

Figure 22. Typical Switching Loss E<sub>on</sub> vs. I<sub>C</sub>

Figure 23. Typical Switching Loss  $E_{on}$  vs.  $R_{G}$ 



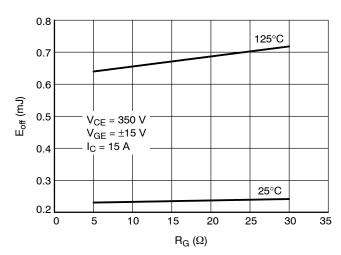
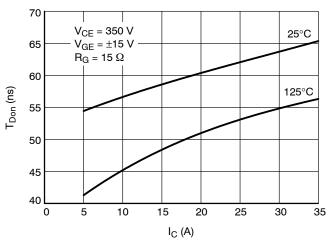


Figure 24. Typical Switching Loss  $E_{off}$  vs.  $I_C$ 

Figure 25. Typical Switching Loss Eoff vs. R<sub>G</sub>



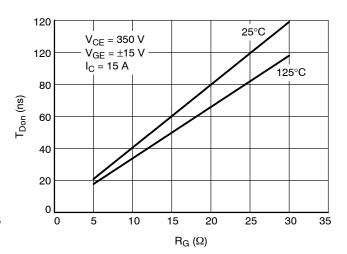
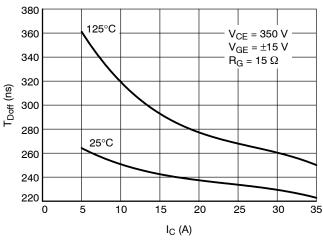


Figure 26. Typical Switching Time  $T_{Don}$  vs.  $I_{C}$ 

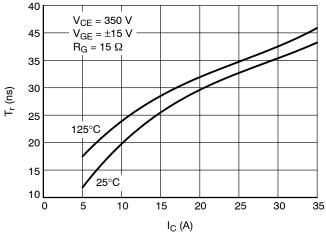
Figure 27. Typical Switching Time  $T_{Don}$  vs.  $R_{G}$ 



500 125°C  $V_{CE} = 350 \text{ V}$ 450  $V_{GE} = \pm 15 \text{ V}$ 400  $I_{\rm C} = 15 \, {\rm A}$ 25°C 350 T<sub>Doff</sub> (ns) 300 250 200 150 100 20 10 15 25 30 35  $R_G(\Omega)$ 

Figure 28. Typical Switching Time  $T_{Doff}$  vs.  $I_{C}$ 

Figure 29. Typical Switching Time  $T_{Doff}$  vs.  $R_{G}$ 



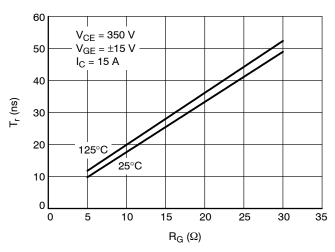
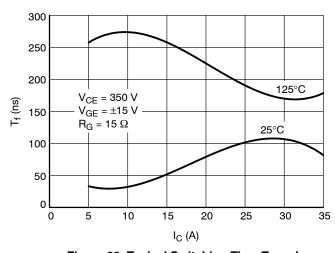


Figure 30. Typical Switching Time  $T_r$  vs.  $I_C$ 

Figure 31. Typical Switching Time  $T_r$  vs.  $R_G$ 



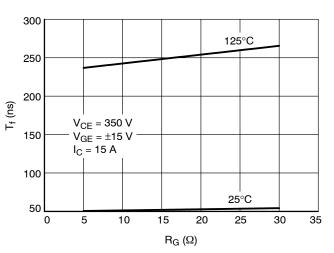
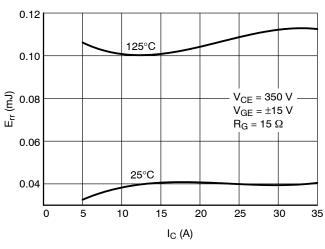


Figure 32. Typical Switching Time  $T_{\rm f}$  vs.  $I_{\rm C}$ 

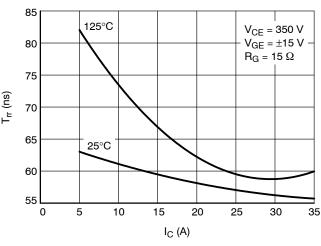
Figure 33. Typical Switching Time T<sub>f</sub> vs. R<sub>G</sub>



0.14 0.12 0.10 125°C  $V_{CE} = 350 \text{ V}$ 80.0 E  $V_{GE} = \pm 15 \text{ V}$ I<sub>C</sub> = 15 A 0.06 0.04 25°C 0.02 20 10 15 25 35  $R_G(\Omega)$ 

Figure 34. Typical Reverse Recovery Energy vs. I<sub>C</sub>

Figure 35. Typical Reverse Recovery Energy vs.  $R_{\mbox{\scriptsize G}}$ 



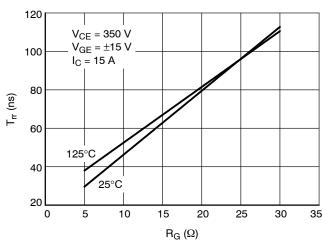
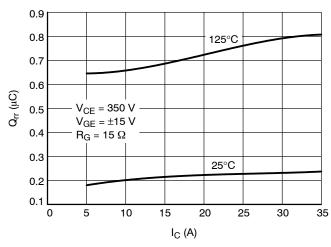


Figure 36. Typical Reverse Recovery Time vs.  $I_{\rm C}$ 

Figure 37. Typical Reverse Recovery Time vs.  $$\rm R_{\rm G}$$ 



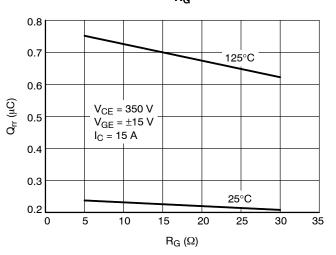
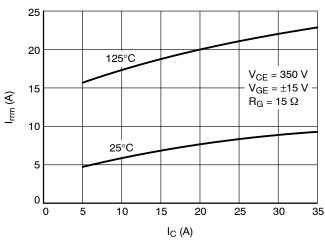


Figure 38. Typical Reverse Recovery Charge vs. I<sub>C</sub>

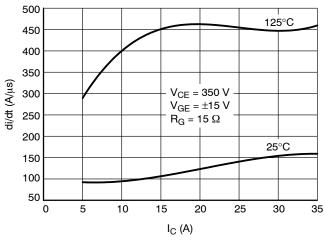
Figure 39. Typical Reverse Recovery Charge vs.  $R_{\rm G}$ 



30 125°C  $V_{CE} = 350 \text{ V}$  $V_{GE}^- = \pm 15 \text{ V}$ 25 I<sub>C</sub> = 15 A 20 I<sub>rrm</sub> (A) 15 25°C 10 5 0 20 0 5 10 15 25 35  $R_G(\Omega)$ 

Figure 40. Typical Reverse Recovery Current vs. I<sub>C</sub>

Figure 41. Typical Reverse Recovery Current vs. R<sub>G</sub>



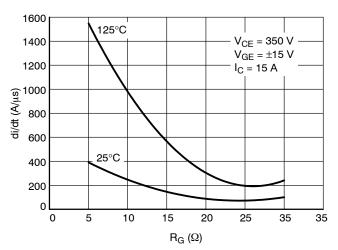
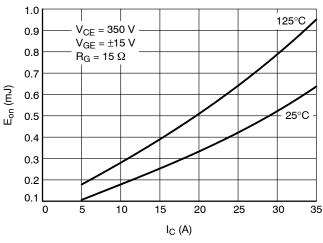


Figure 42. Typical di/dt vs. I<sub>C</sub>

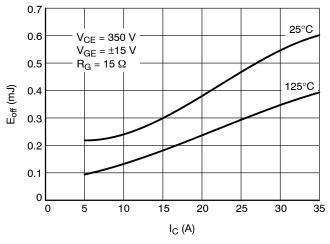
Figure 43. Typical di/dt vs. R<sub>G</sub>



0.55 125°C  $V_{CE} = 350 \text{ V}$ 0.50  $V_{GE} = \pm 15 \text{ V}$ 0.45  $I_{C} = 15 A$ 0.40 E<sub>on</sub> (mJ) 25°C 0.35 0.30 0.25 0.20 0.15 20 15 25 35  $R_G(\Omega)$ 

Figure 44. Typical Switching Energy Eon vs. IC

Figure 45. Typical Switching Energy  $E_{on}$  vs.  $R_{G}$ 



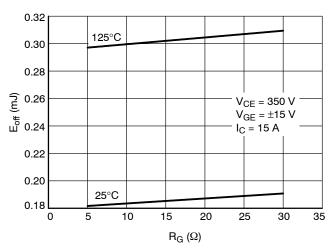
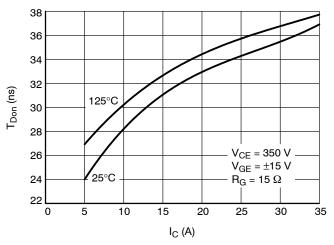


Figure 46. Typical Switching Energy Eoff vs. IC

Figure 47. Typical Switching Energy  $\mathsf{E}_{\mathsf{off}}$  vs.  $\mathsf{R}_{\mathsf{G}}$ 



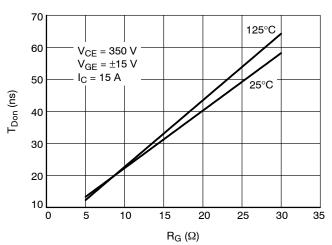
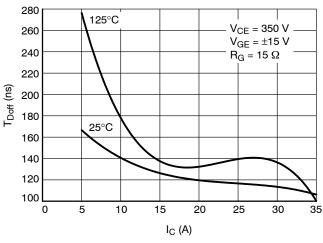


Figure 48. Typical Switching Time  $T_{Don}$  vs.  $I_{C}$ 

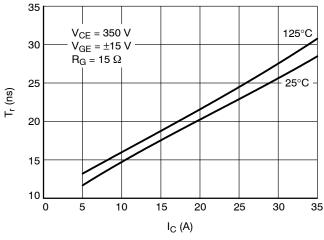
Figure 49. Typical Switching Time  $T_{Don}$  vs.  $R_{G}$ 



240 125°C V<sub>CE</sub> = 350 V 220  $V_{GE} = \pm 15 \text{ V}$ 200  $I_{C} = 15 A$ 180 . 25°C 160 140 120 100 80 60 20 15 25 30 35  $R_G(\Omega)$ 

Figure 50. Typical Switching Time  $T_{Doff}$  vs.  $I_{C}$ 

Figure 51. Typical Switching Time  $T_{Doff}$  vs.  $R_{G}$ 



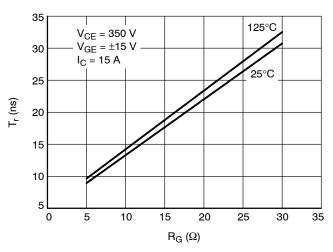
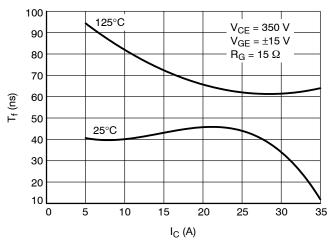


Figure 52. Typical Switching Time  $T_r$  vs.  $I_C$ 

Figure 53. Typical Switching Time  $T_r$  vs.  $R_G$ 



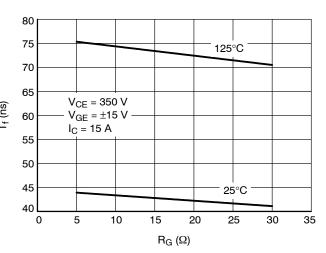
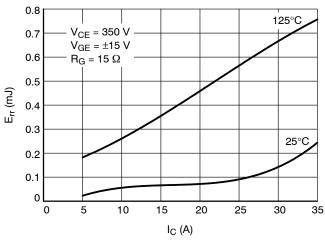


Figure 54. Typical Switching Time  $T_f$  vs.  $I_C$ 

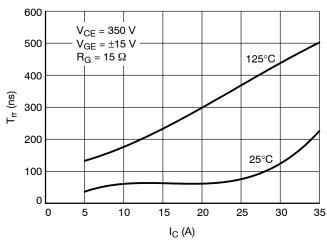
Figure 55. Typical Switching Time T<sub>f</sub> vs. R<sub>G</sub>



0.45 125°C 0.40 0.35 0.30 0.25 占 0.20 V<sub>CE</sub> = 350 V  $V_{GE} = \pm 15 \text{ V}$ 0.15 I<sub>C</sub> = 15 A 25°C 0.10 0.05 n 15 20 35  $R_G(\Omega)$ 

Figure 56. Typical Reverse Recovery Energy vs. I<sub>C</sub>

Figure 57. Typical Reverse Recovery Energy vs. R<sub>G</sub>



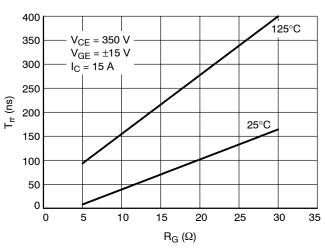
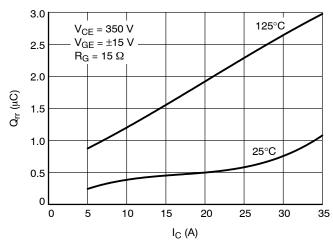


Figure 58. Typical Reverse Recovery Time vs.  $\ensuremath{\text{I}_{\text{C}}}$ 

Figure 59. Typical Reverse Recovery Time vs.  $$\rm R_{\rm G}$$ 



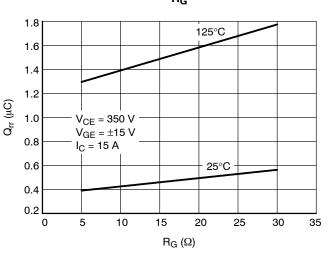
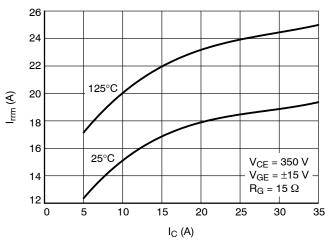


Figure 60. Typical Reverse Recovery Charge vs. I<sub>C</sub>

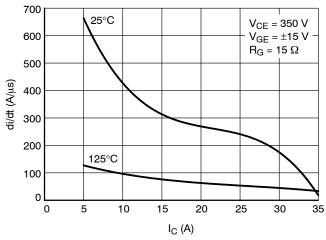
Figure 61. Typical Reverse Recovery Charge vs. R<sub>G</sub>



35 125°C  $V_{CE} = 350 \text{ V}$ 30  $V_{GE}^{-} = \pm 15 \text{ V}$  $I_{C} = 15 A$ 25 25°C Irrm (A) 20 15 10 5 15 20 25 35  $R_G(\Omega)$ 

Figure 62. Typical Reverse Recovery Current vs. I<sub>C</sub>

Figure 63. Typical Reverse Recovery Current vs. R<sub>G</sub>



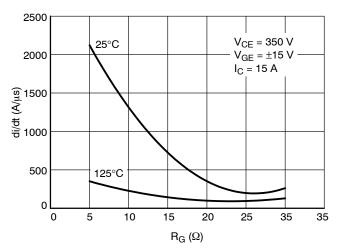


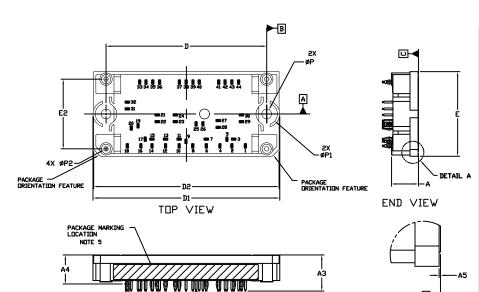
Figure 64. Typical di/dt vs. I<sub>C</sub>

Figure 65. Typical di/dt vs. R<sub>G</sub>

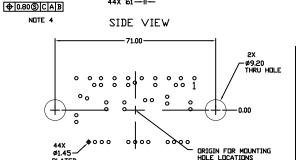


# PIM44, 71x37.4 (PRESSFIT PINS) CASE 180AS ISSUE O

**DATE 25 JUN 2018** 



	PIN PE	ISITION		PIN POSITION	
PIN	Х	Υ	PIN	Х	Υ
1	26.10	14.10	23	-4.85	3.40
2	20.10	14.10	24	-4.85	0.40
3	20.90	11.10	25	4.30	4.40
4	14.80	14.10	26	7.30	4.40
5	17.90	11.10	27	14.05	2.90
6	8.80	14.10	28	14.05	5.90
7	8.80	11.10	29	24.35	3.40
8	2.80	14.10	30	24.35	0.40
9	-0.20	12.10	31	-26.10	-2.25
10	-3.20	14.10	32	-26.10	-5.25
11	-3.20	11.10	33	-20.65	-14.10
12	-9.20	14.10	34	-17.85	-14.10
13	-9.20	11.10	35	-14.85	-14.10
14	-15.20	14.10	36	-11.85	-14.10
15	-15.20	11.10	37	-3.10	-14.10
16	-20.10	14.10	38	-0.10	-14.10
17	-18.20	11.10	39	2.90	-14.10
18	-26.10	14.10	40	5.70	-14.10
19	-21.35	5.20	41	14.30	-14.10
20	-24.35	6.20	42	17.10	-14.10
21	-12.85	0.40	43	20.10	-14.10
22	-12.85	3.40	44	23.10	-14.10



RECOMMENDED MOUNTING PATTERN

#### NOTES:

PLATED THRU HOLE

44Y h

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
- 2. CONTROLLING DIMENSION: MILLIMETERS
- 3. DIMENSIONS 6 AND 61 APPLY TO THE PLATED
  TERMINALS AND ARE MEASURED AT DIMENSION A4.
- 4. POSITION OF THE CENTER OF THE TERMINALS IS DETERMINED FROM DATUM B THE CENTER OF DIMENSION D, X DIRECTION, AND FROM DATUM A, Y DIRECTION. POSITIONAL TOLERANCE, AS NOTED IN DRAWING, APPLIES TO EACH TERMINAL IN BOTH DIRECTIONS.
- PACKAGE MARKING IS LOCATED AS SHOWN ON THE SIDE OPPOSITE THE PACKAGE ORIENTATION FEATURES.

NΠ	т	E	4	
~~	٠	_	-	

DETAIL A

**MILLIMETERS** 

N□M.

12.00

16.00

12.83 BSC

0.20

1.66

0.80

71.00

82.50

82.00

37.40

30.80

4.30

9.50

2.00

12.50

16.50

0.30

1.71

0.85 71.50

83.00

82.50

37.90

31.30

4.50

9.70

2.20

MIN.

A3

Α4

Α5

b

b1

D

D1

D2

Ε

E2

Р

P1

P2

11.50

15.50

0.10

1.61

0.75

70.50

82.00

81.50

36.90

30.30

4.10

9.30

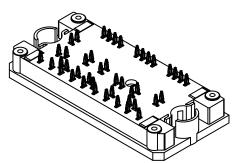
1.80

	PIN P	NDITIZE		PIN P	NOITIE
PIN	х	Υ	PIN	×	Y
1	26.10	-14.10	23	-4.85	-3.40
2	20.10	-14.10	24	-4.85	-0.40
3	20.90	-11.10	25	4.30	-4.40
4	14.80	-14.10	26	7.30	-4.40
5	17.90	-11.10	27	14.05	-2.90
6	8.80	-14.10	28	14.05	-5.90
7	8.80	-11.10	29	24.35	-3.40
8	2.80	-14.10	30	24.35	-0.40
9	-0.20	-12.10	31	-26.10	2.25
10	-3.20	-14.10	32	-26.10	5.25
11	-3.20	-11.10	33	-20.65	14.10
12	-9.20	-14.10	34	-17.85	14.10
13	-9.20	-11.10	35	-14.85	14.10
14	-15.20	-14.10	36	-11.85	14.10
15	-15.20	-11.10	37	-3.10	14.10
16	-20.10	-14.10	38	-0.10	14.10
17	-18.20	-11.10	39	2.90	14.10
18	-26.10	-14.10	40	5.70	14.10
19	-21.35	-5.20	41	14.30	14.10
20	-24.35	-6.20	42	17.10	14.10
21	-12.85	-0.40	43	20.10	14.10
22	-12.85	-3.40	44	23.10	14.10

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PIM44, 71x37.4 CASE 180AS ISSUE O

**DATE 15 JUN 2018** 

# GENERIC MARKING DIAGRAM\*

XXXXX = Specific Device Code
G = Pb-Free Package
AT = Assembly & Test Site Code
YYWW = Year and Work Week Code

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

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